

<b>Notice of References Cited</b>	Application/Control No. 10/690,928	Applicant(s)/Patent Under Reexamination HAN ET AL.	
	Examiner Thao X. Le	Art Unit 2814	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,068,782	05-2000	Brandt et al.	216/17
	B	US-6,236,572	05-2001	Teshome et al.	361/794
	C	US-6,910,266	06-2005	Lee et al.	29/832
	D	US-6,826,333	11-2004	Catchmark et al.	385/37
	E	US-2002/0048137	04-2002	Williams et al.	361/302
	F	US-5,261,153	11-1993	Lucas, Gregory L.	29/830
	G	US-5,260,170	11-1993	Brown, Vernon L.	430/315
	H	US-5,891,606	04-1999	Brown, Vernon L.	430/312
	I	US-6,349,456	02-2002	Dunn et al.	29/25.42
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.